

HD14501UB

Triple Gate

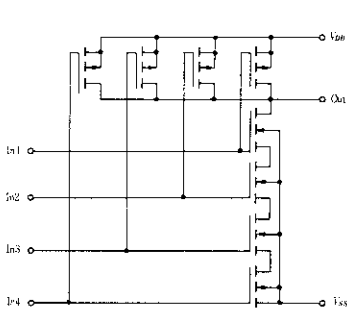
- (Dual 4-input NAND Gate)
- 2-input NOR/OR Gate
- 8-input AND/NAND Gate

FEATURES

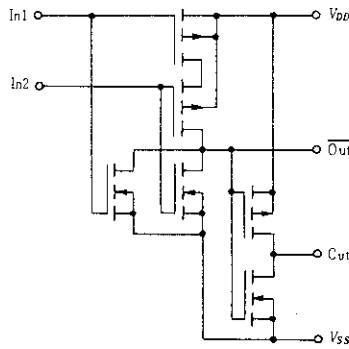
- Quiescent Current = 0.5nA typ/pkg @5V
- Noise Immunity = 45% of V_{DD} typ
- Capable of Driving One Low-power Schottky TTL Load Over the Rated Temperature Range
- Pin-for Pin Replacements for MC14501UB Series

CIRCUIT SCHEMATIC

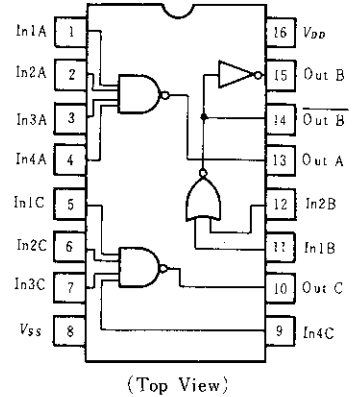
4-input NAND Gate



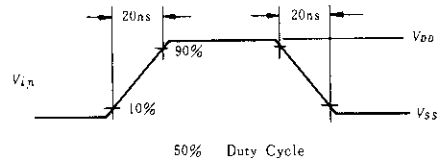
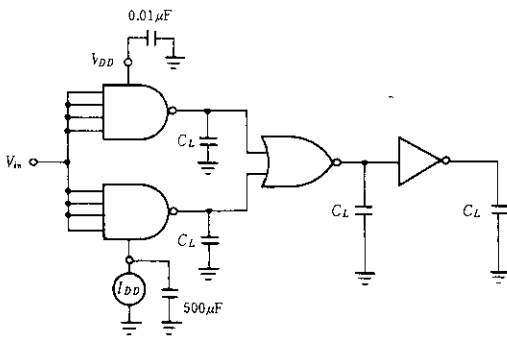
2-input NOR/OR Gate



PIN ARRANGEMENT



POWER DISSIPATION TEST CIRCUIT AND WAVEFORM



■ ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	V _{DD} (V)	Test Conditions	-40°C		25°C			85°C		Unit			
				min	max	min	typ	max	min	max				
Output Voltage	V _{OL}	5.0	V _{in} =V _{DD} or 0	-	0.05	-	0	0.05	-	0.05	V			
		10		-	0.05	-	0	0.05	-	0.05				
		15		-	0.05	-	0	0.05	-	0.05				
	V _{OH}	5.0	V _{in} =0 or V _{DD}	4.95	-	4.95	5.0	-	4.95	-	V			
		10		9.95	-	9.95	10	-	9.95	-				
		15		14.95	-	14.95	15	-	14.95	-				
Input Voltage	V _{IL}	5.0	V _{out} =4.5 or 0.5V	-	1.0	-	2.25	1.0	-	1.0	V			
		10	V _{out} =9.0 or 1.0V	-	2.0	-	4.50	2.0	-	2.0				
		15	V _{out} =13.5 or 1.5V	-	2.5	-	6.75	2.5	-	2.5				
	V _{IH}	5.0	V _{out} =0.5 or 4.5V	4.0	-	4.0	2.75	-	4.0	-	V			
		10	V _{out} =1.0 or 9.0V	8.0	-	8.0	5.50	-	8.0	-				
		15	V _{out} =1.5 or 13.5V	12.5	-	12.5	8.25	-	12.5	-				
Output Drive Current	NAND	I _{OH}	5.0	V _{OH} =2.5V	-1.0	-	-0.8	-1.7	-	-0.6	mA			
			5.0	V _{OH} =4.6V	-0.2	-	-0.16	-0.36	-	-0.12				
			10	V _{OH} =9.5V	-0.5	-	-0.4	-0.9	-	-0.3				
			15	V _{OH} =13.5V	-1.4	-	-1.2	-3.5	-	-1.0				
	NOR		5.0	V _{OH} =2.5V	-1.68	-	-1.4	-3.0	-	-1.05		-		
			5.0	V _{OH} =4.6V	-0.34	-	-0.28	-0.63	-	-0.21				
			10	V _{OH} =9.5V	-0.84	-	-0.7	-1.58	-	-0.52				
			15	V _{OH} =13.5V	-2.52	-	-2.1	-6.12	-	-1.57				
	NOR-Inverter		5.0	V _{OH} =2.5V	-2.88	-	-2.4	-5.1	-	-1.8		-		
			5.0	V _{OH} =4.6V	-0.58	-	-0.48	-1.08	-	-0.36				
			10	V _{OH} =9.5V	-1.44	-	-1.2	-2.7	-	-0.9				
	NAND		I _{OL}	5.0	V _{OL} =0.4V	0.52	-	0.44	0.88	-		0.36	mA	
		10		V _{OL} =0.5V	1.3	-	1.1	2.25	-	0.9				
		15		V _{OL} =1.5V	3.6	-	3.0	8.8	-	2.4				
		NOR		5.0	V _{OL} =0.4V	0.79	-	0.66	1.32	-	0.54	-		
10				V _{OL} =0.5V	1.98	-	1.65	3.37	-	1.36				
15				V _{OL} =1.5V	5.4	-	4.5	13.2	-	3.57				
NOR-Inverter		5.0		V _{OL} =0.4V	1.32	-	1.1	2.2	-	0.90	-			
		10		V _{OL} =0.5V	3.3	-	2.75	5.63	-	2.27				
		15		V _{OL} =1.5V	9.0	-	7.5	22.0	-	5.95				
Input Current		I _{in}		15		-	±0.3	-	±0.00001	±0.3	-	±1.0		μA
Input Capacitance		C _{in}			V _{in} =0	-	-	-	5.0	7.5	-	-		pF
Quiescent Current		I _{DD}		5.0	Zero Signal, per Package	-	0.5	-	0.0005	0.5	-	3.8		μA
	10		-	1.0		-	0.0010	1.0	-	7.5				
	15		-	2.0		-	0.0015	2.0	-	15				
Total Supply Current*	I _T	5.0	Dynamic + I _{DD} , per Gate	-	-	-	1.2	-	-	-	μA			
		10	-	-	-	2.4	-	-	-					
		15	C _L =50pF, f=1kHz	-	-	-	3.6	-	-	-				

* To calculate total supply current at frequency other than 1kHz.

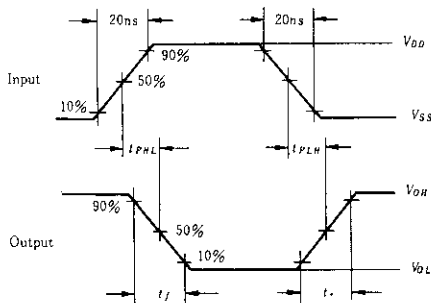
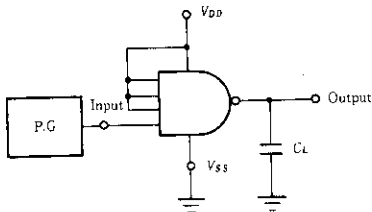
Ⓒ V_{DD}=5.0V I_T=(1.2μA/kHz)/f+I_{DD}. Ⓒ V_{DD}=10V I_T=(2.4μA/kHz)/f+I_{DD}. Ⓒ V_{DD}=15V I_T=(3.6μA/kHz)/f+I_{DD}

■ SWITCHING CHARACTERISTICS ($C_L=50\text{pF}$, $T_a=25^\circ\text{C}$)

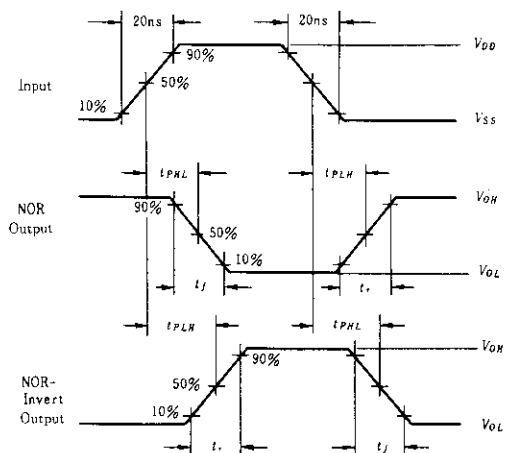
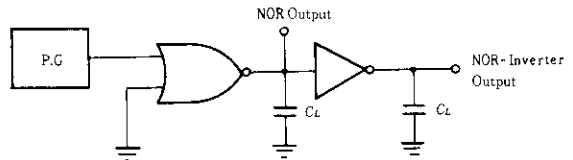
Characteristic		Symbol	Test Circuit	$V_{DD}(\text{V})$	min	typ	max	Unit
Output Rise Time	NAND, NOR	t_r	1, 2	5.0	—	180	400	ns
				10	—	90	200	
				15	—	65	160	
	NOR-Inverter		2	5.0	—	100	200	
				10	—	50	100	
				15	—	37	80	
Output Fall Time	NAND, NOR	t_f	1, 2	5.0	—	100	200	ns
				10	—	50	100	
				15	—	37	80	
	NOR-Inverter		2	5.0	—	60	140	
				10	—	40	100	
				15	—	30	75	
Propagation Delay Time	NAND	t_{PLH} , t_{PHL}	1	5.0	—	130	300	ns
				10	—	70	175	
	NOR		2	5.0	—	115	250	
				10	—	65	160	
	NOR-Inverter		2	5.0	—	130	300	
				10	—	70	175	
				15	—	50	125	

■ SWITCHING TIME TEST CIRCUIT

1. NAND Gate



2. NOR Gate, NOR-Inverter





Hitachi Code	DP-16
JEDEC	Conforms
EIAJ	Conforms
Weight (reference value)	1.07 g

Cautions

1. Hitachi neither warrants nor grants licenses of any rights of Hitachi's or any third party's patent, copyright, trademark, or other intellectual property rights for information contained in this document. Hitachi bears no responsibility for problems that may arise with third party's rights, including intellectual property rights, in connection with use of the information contained in this document.
2. Products and product specifications may be subject to change without notice. Confirm that you have received the latest product standards or specifications before final design, purchase or use.
3. Hitachi makes every attempt to ensure that its products are of high quality and reliability. However, contact Hitachi's sales office before using the product in an application that demands especially high quality and reliability or where its failure or malfunction may directly threaten human life or cause risk of bodily injury, such as aerospace, aeronautics, nuclear power, combustion control, transportation, traffic, safety equipment or medical equipment for life support.
4. Design your application so that the product is used within the ranges guaranteed by Hitachi particularly for maximum rating, operating supply voltage range, heat radiation characteristics, installation conditions and other characteristics. Hitachi bears no responsibility for failure or damage when used beyond the guaranteed ranges. Even within the guaranteed ranges, consider normally foreseeable failure rates or failure modes in semiconductor devices and employ systemic measures such as fail-safes, so that the equipment incorporating Hitachi product does not cause bodily injury, fire or other consequential damage due to operation of the Hitachi product.
5. This product is not designed to be radiation resistant.
6. No one is permitted to reproduce or duplicate, in any form, the whole or part of this document without written approval from Hitachi.
7. Contact Hitachi's sales office for any questions regarding this document or Hitachi semiconductor products.

HITACHI

Hitachi, Ltd.

Semiconductor & Integrated Circuits.
Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan
Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

URL North America : <http://semiconductor.hitachi.com/>
Europe : <http://www.hitachi-eu.com/hel/ecg>
Asia (Singapore) : <http://www.has.hitachi.com.sg/grp3/sicd/index.htm>
Asia (Taiwan) : http://www.hitachi.com.tw/E/Product/SICD_Frame.htm
Asia (HongKong) : <http://www.hitachi.com.hk/eng/bo/grp3/index.htm>
Japan : <http://www.hitachi.co.jp/Sicd/indx.htm>

For further information write to:

Hitachi Semiconductor
(America) Inc.
179 East Tasman Drive,
San Jose, CA 95134
Tel: <1> (408) 433-1990
Fax: <1> (408) 433-0223

Hitachi Europe GmbH
Electronic components Group
Dornacher Straße 3
D-85622 Feldkirchen, Munich
Germany
Tel: <49> (89) 9 9180-0
Fax: <49> (89) 9 29 30 00

Hitachi Europe Ltd.
Electronic Components Group.
Whitebrook Park
Lower Cookham Road
Maidenhead
Berkshire SL6 8YA, United Kingdom
Tel: <44> (1628) 585000
Fax: <44> (1628) 778322

Hitachi Asia Pte. Ltd.
16 Collyer Quay #20-00
Hitachi Tower
Singapore 049318
Tel: 535-2100
Fax: 535-1533

Hitachi Asia Ltd.
Taipei Branch Office
3F, Hung Kuo Building, No.167,
Tun-Hwa North Road, Taipei (105)
Tel: <886> (2) 2718-3666
Fax: <886> (2) 2718-8180

Hitachi Asia (Hong Kong) Ltd.
Group III (Electronic Components)
7/F., North Tower, World Finance Centre,
Harbour City, Canton Road, Tsim Sha Tsui,
Kowloon, Hong Kong
Tel: <852> (2) 735 9218
Fax: <852> (2) 730 0281
Telex: 40815 HITEC HX

Copyright ' Hitachi, Ltd., 1999. All rights reserved. Printed in Japan.

HITACHI